

# **Dual P-Channel 30-V (D-S) MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ )	$R_{DS(on)}(\Omega)$ $I_D(A)^{d, e}$ $Q_g(Ty)$		
- 30	0.012 at V <sub>GS</sub> = - 10 V	- 9.9	15 nC	
- 30	0.018 at V <sub>GS</sub> = - 4.5 V	- 8.4	15 110	

#### **FEATURES**

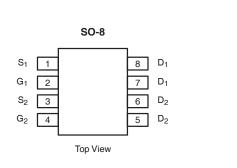
- DT-Trench Power MOSFET
- 100 % UIS Tested

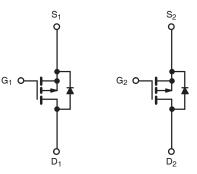
# Pb-free

## RoHS

#### **APPLICATIONS**

• Load Switches





P-Channel MOSFET

P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
	T <sub>C</sub> = 25 °C		- 9.9 <sup>e</sup>	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	1 , 🗀	- 8.5 <sup>e</sup>	
Continuous Diam Curient (1) = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 8.2 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C	1	- 6.6 <sup>a, b</sup>	Α .
Pulsed Drain Current		I <sub>DM</sub>	- 42 <sup>e</sup>	A
	T <sub>C</sub> = 25 °C		- 4.9	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 2.9 <sup>a, b</sup>	
Avalanche Current	1 0411	I <sub>AS</sub>	- 26	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	28	mJ
	T <sub>C</sub> = 25 °C		5.5	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	1 , —	3.7	14/
	T <sub>A</sub> = 25 °C	- P <sub>D</sub>	2.5 <sup>a, b</sup>	W
	T <sub>A</sub> = 70 °C	1	1.6 <sup>a, b</sup>	
Operating Junction and Storage Temperature Rang	T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	R <sub>thJA</sub>	25	40	°C/W	
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	15	22	]	

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under Steady State conditions is 85  $^{\circ}\text{C/W}.$
- d. Based on  $T_C = 25$  °C.
- e. Limited by package.



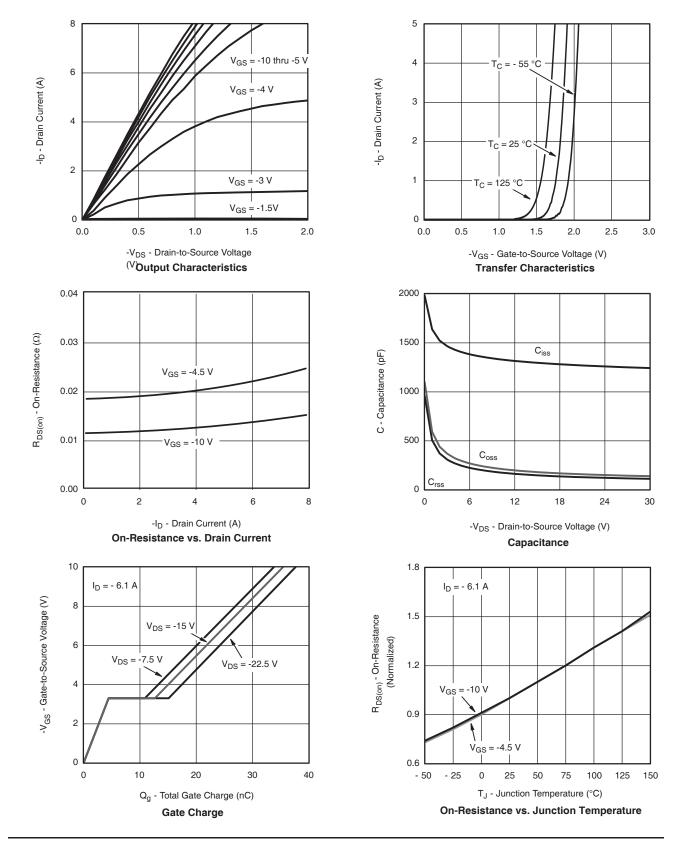
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, } I_D = -250  \mu\text{A}$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 31		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			4.5			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1		
		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 36			Α	
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 6.3 A		0.012	0.016	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 6.2 A		0.018	0.025		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 6.1 A		23		S	
Dynamic <sup>b</sup>					<b>.</b>		
Input Capacitance	C <sub>iss</sub>			1390			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		202		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	1	179			1	
Tabal Cada Classica	$Q_g$ $V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -6.1 \text{ A}$	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 6.1 A		32	50		
Total Gate Charge			15	25			
Gate-Source Charge	Q <sub>gs</sub>	$Q_{gs}$ $V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -6.1 \text{ A}$		4		nC	
Gate-Drain Charge	Q <sub>qd</sub>	1		7.5		1	
Gate Resistance	R <sub>q</sub>	f = 1 MHz		5.8		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15		
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 15 \Omega$		8	15		
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -1 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		45	70		
Fall Time	t <sub>f</sub>	1		12	25		
Turn-On Delay Time	t <sub>d(on)</sub>			42	70	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 15 \Omega$		35	60	1	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong$ - 1 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		40	70	]	
Fall Time	t <sub>f</sub>	1		16	30		
<b>Drain-Source Body Diode Characterist</b>	ics			•			
Continous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 8.6	۸	
Pulse Diode Forward Current	I <sub>SM</sub>				- 40	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = -2 A, V <sub>GS</sub> = 0 V		- 0.75	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			34	60	ns	
Body Diode Reverse Recovery Charge O		]   OA di/da 100 A/: T 05:00		22	40	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			11			
Reverse Recovery Rise Time	t <sub>b</sub>	1		23		ns	

#### Notes:

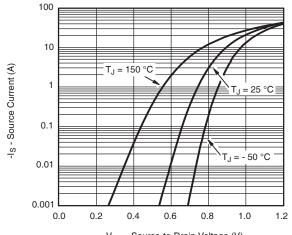
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

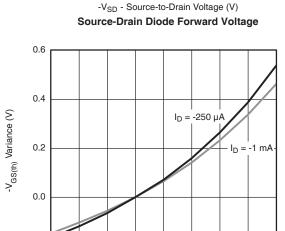
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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T<sub>J</sub> - Temperature (°C)

Threshold Voltage

50

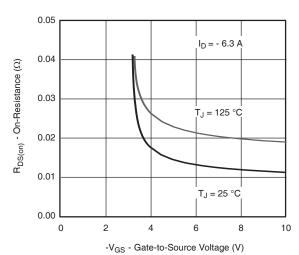
75

100

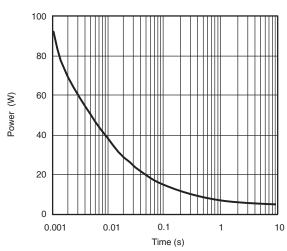
125

150

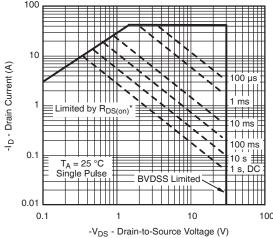
25



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



\* V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

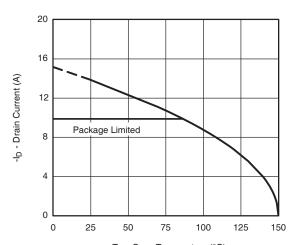
Safe Operating Area

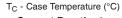
- 0.2

- 25

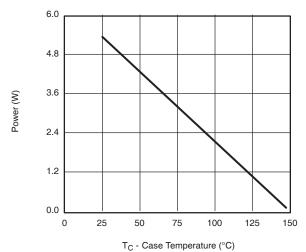


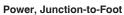
# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

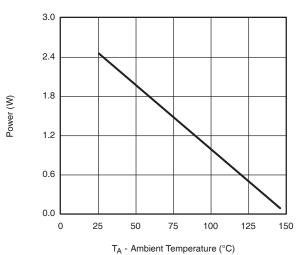




#### Current Derating\*





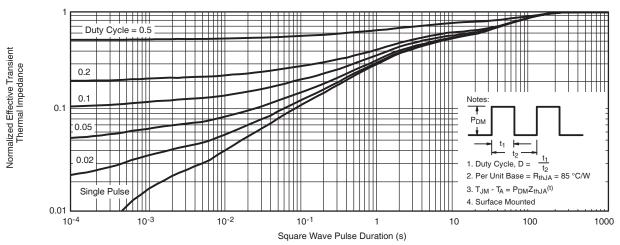


Power Derating, Junction-to-Ambient

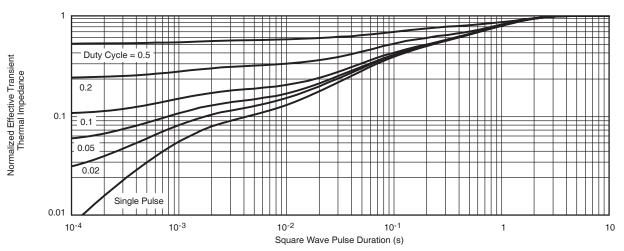
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot





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